

# **Integrated Passives Technology Embedded Capacitor Films (ECFs) and Ink-Jet Resistors**

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# **Integrated Passives Technology Embedded Capacitor Films (ECFs) and Ink-Jet Resistors**

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**KAIST**

**Micro-Electronic Packaging Lab.**

**SMT/PCB Korea 2003**

**COEX, Seoul Korea**

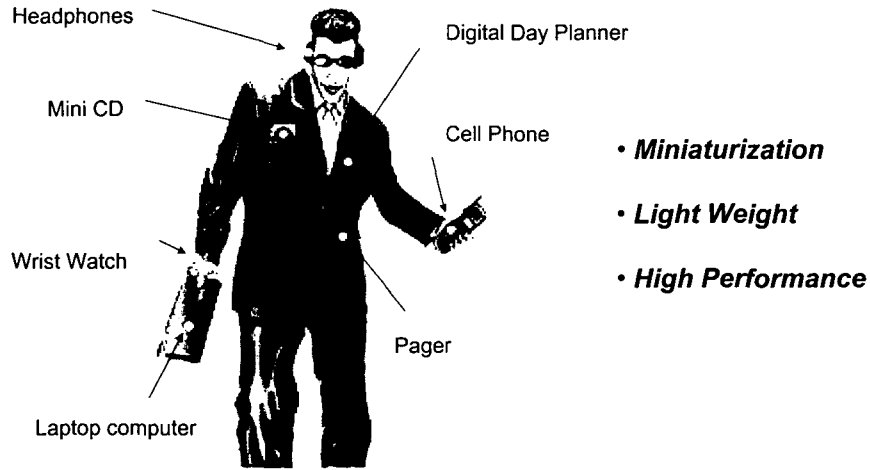
**2003/4/9**

## ***Outline***

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- **Introduction**
  - ✓ **Embedded Capacitors & Resistors**
- **Embedded Capacitors**
  1. **Embedded Capacitor Films(ECFs) Fabrication**
  2. **Properties of ECFs**
    - ✓ **Tolerance**
    - ✓ **Dielectric Constant**
    - ✓ **Leakage Current**
    - ✓ **Adhesion Strength**
- **Embedded Resistors**
  - ✓ **Ink-jet resistors fabrication**

## Trends of Electronic Packaging



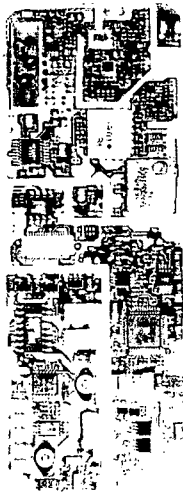
- Miniaturization
- Light Weight
- High Performance

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## Active Components vs. Passive Components

### • Cellular phone



제품	수동소자 수	전체 IC 수	비율
<b>휴대폰</b>			
Ericsson DH338 Digital	359	25	14:1
Ericsson H237 Analog	243	14	17:1
Philips PR93 Analog	283	11	25:1
Nokia2110 Digital	432	21	20:1
Motorola Mrl 1.8 GHz	389	27	14:1
Casio PH-250	373	29	13:1
Motorola StarTAC	993	45	22:1
Matsushita NTT DoCoMo	492	30	16:1
<b>휴대용 전자 제품</b>			
Motorola Tango Pager	437	15	29:1
Casio QV10 Digital Camera	489	17	29:1
1990 Sony Camcorder	1226	14	33:1
Sony Handy Cam DCR-PC7	1329	13	31:1
<b>기타 통신 제품</b>			
Motorola Pen Pager	142	3	47:1
Infotac Radio Modem	585	24	24:1
Data Race Fax-Modem	101	8	13:1
<b>PDA</b>			
Sony Magic Link	538	74	7:1

휴대폰의 경우 수동 소자가 PCB 면적의 50% 이상 차지

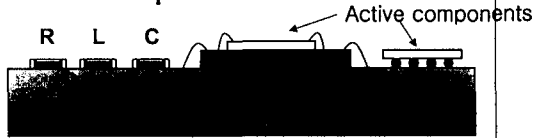
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## Embedded Passives

### What is Embedded Passives?

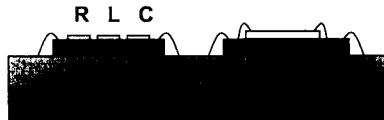
#### Discrete passives



#### Embedded passives



#### Integrated passives



### Advantages of Embedded Passives

- Smaller area
- Shorter interconnection length (low parasitic loss)
- Less solder joints



- Miniaturization
- Higher electrical performance
- Better reliability

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## Applications of Embedded Passives

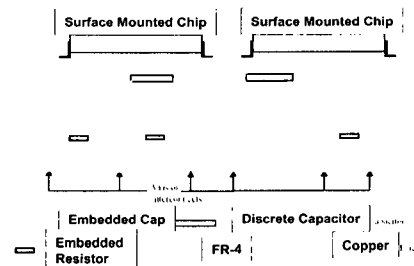
### Resistors (50%)

- Termination resistors (20~100  $\Omega$ )
- Pull-up/down resistors (1~30 K $\Omega$ )

### Capacitors (40%)

- Decoupling capacitor for simultaneous switching noise(SSN) suppression (10~100 nF)
- Bypass, EMI filter, timing capacitor (10~100 pF)

### Inductors (10%)



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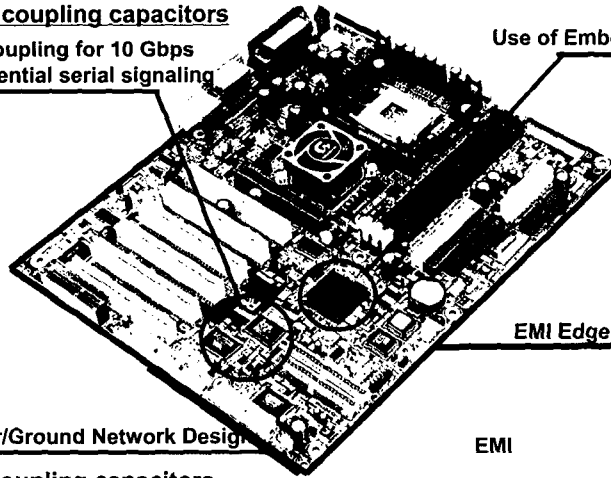
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## Applications of Embedded Capacitors

- AC coupling capacitors

AC coupling for 10 Gbps differential serial signaling

Use of Embedded Cap. In Package



EMI Edge Radiation Reduction

Power/Ground Network Design

EMI

- Decoupling capacitors

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## *Embedded Capacitors*

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## Material Candidates for Embedded Capacitors

### ■ Requirements for embedded capacitors materials for organic substrate

- High dielectric constant (high capacitance)
- Processability (low process temperature)
- Low tolerance (< ±5%)
- Low cost

$$\frac{C}{A} = \epsilon_0 \epsilon_r \frac{1}{d}$$

Type	Materials	공정 온도	유전 상수	두께	Specific Capacitance	
Thin film	Al <sub>2</sub> O <sub>3</sub>	moderate	6~9	200~500 nm	20 (nF/cm <sup>2</sup> )	
	DLC					
	Ta <sub>2</sub> O <sub>5</sub>					
	TiO <sub>2</sub>	25	200~500 nm	100		
	Pb(Zr,Ti)O <sub>3</sub> -PZT (Ba,Sr)TiO <sub>3</sub> -BST	Very high	Very high	-	-	
Thick film	BaTiO <sub>3</sub> Powder PMN-PT powder	Epoxy resin Polyimide	low	High	2.5 μm	22

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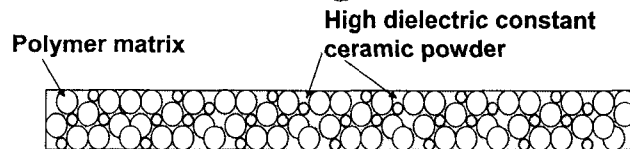
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## Why Polymer/Ceramic Composite?

High dielectric constant of ceramic powders

+

Good processability & Low cost of polymers



### ● Epoxy/BaTiO<sub>3</sub> composite

- BaTiO<sub>3</sub>: well-known high dielectric constant ceramic powder
- Epoxy: compatible with PWB

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## **Current Status**

### **in Polymer/Ceramic Composite Capacitors**

#### ■ **Spin coating method using colloidal solution**

- Thin dielectric layer formation
- High waste of materials (>90%)
- Large capacitance tolerance
  - Non-uniform coating thickness over large area

#### ■ 유사 제품 상용화 현황 – 초보적 수준

- 3M : 유전상수 15~23의 제품 상용화 – 낮은 유전상수
- Dupont: 유전상수 10의 제품 상용화 – 낮은 유전상수
- Sanmina 특허

**New Capacitor Materials are needed!!!**

## ➤ **Embedded Capacitors**

### **1.Embedded Capacitor Films(ECFs) Fabrication**

### **2.Properties of ECFs**

- ✓Tolerance
- ✓Dielectric Constant
- ✓Leakage Current
- ✓Adhesion Strength



## **Material Formulation for ECFs**

### **□ Ceramic powders & Polymers**

- ❖ High dielectric constant BaTiO<sub>3</sub> nano-powder
- ❖ Specially formulated polymer resin

• Thermosetting Epoxy

• Thermoplastic

• Thermal stability & Adhesion strength after curing

• Good film formation capability  
• Film flexibility in B-stage

- Epoxy curing agent
- Dispersion agent
- Solvent

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## **Film formation process**

### **□ ECF fabrication procedure**

BT powder, dispersant, solvent mixing

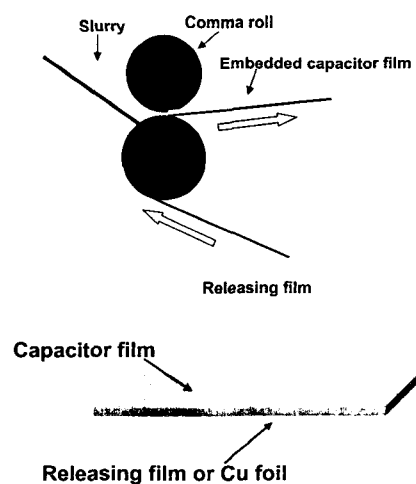
Ultrasonic & ball milling

Polymer resin & curing agent mixing

Ball milling

Film coating on releasing film or metal foil

Solvent drying

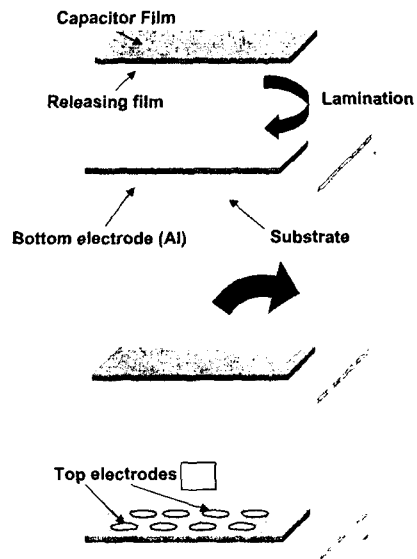
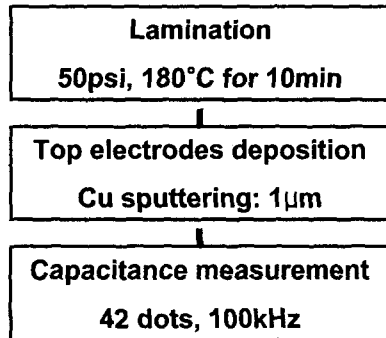


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## Capacitors Fabrication Process

□ Capacitors fabrication & measurement

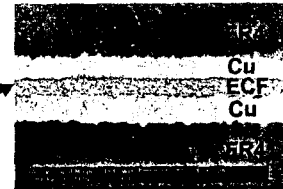
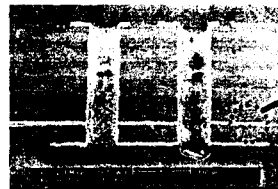
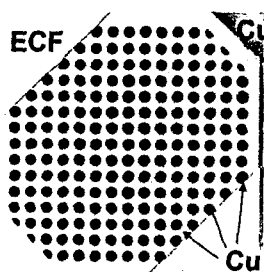
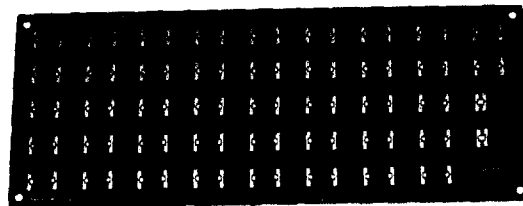


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## ECF Fabricated on PCB

14 cm x 5.5 cm



x50

x500

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## ➤ Embedded Capacitors

### 1. Embedded Capacitor Films(ECFs) Fabrication

### 2. Properties of ECFs

- ✓ Tolerance
- ✓ Dielectric Constant
- ✓ Leakage Current
- ✓ Adhesion Strength

## Characteristics of ECF Capacitors

### Typical tolerance of ECF capacitors

	Bimodal
Thickness	10 $\mu\text{m}$
Thickness Tolerance( $3\sigma$ )	$\pm 2.9\%$
Dielectric constant	93
Dielectric loss	0.03
Specific capacitance	8.24 nF/cm <sup>2</sup>
Capacitance tolerance ( $3\sigma$ )	$\pm 4.8\%$
Leakage current (A/cm <sup>2</sup> ) at 10V	$5.0 \times 10^{-8}$ A/cm <sup>2</sup>

### Test conditions

- Test sample size: 10cm×10cm
  - Number of dots: 50
  - Total number of dots tested: 200
  - Dot area: 0.126 cm<sup>2</sup>
- $Tolerance(\%) = 100 \times 3\sigma / \bar{R}$

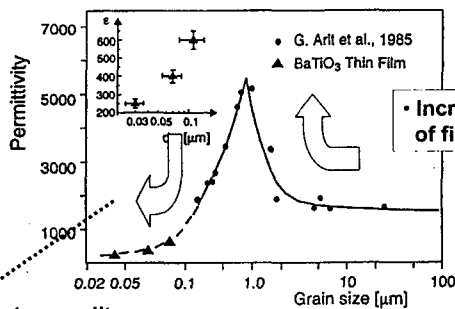
## ➤ Embedded Capacitors

### 1. Embedded Capacitor Films(ECFs) Fabrication

### 2. Properties of ECFs

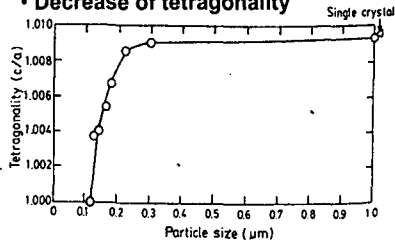
- ✓ Tolerance
- ✓ Dielectric Constant
- ✓ Leakage Current
- ✓ Adhesion Strength

## Dependence of Dielectric Constant of BaTiO<sub>3</sub> on Grain Size



• Increase of 90° domain wall of fine grained BaTiO<sub>3</sub>

• Decrease of tetragonality



• K. Uchino et al., *J. Am. Ceram. Soc.*, 72 (1989)

• G. Arlt et al., *J. Appl. Phys.*, 58 (1985)

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## ***BaTiO<sub>3</sub> Powder Size***

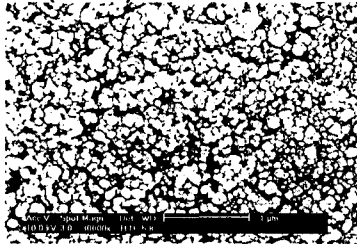
Powder #	Particle size ( $\mu\text{m}$ )		Spec. surface area ( $\text{m}^2/\text{g}$ ) by BET
	Median dia. ( $d_m$ )	Average dia. ( $d_g$ )	
A	0.06 (0.1)		16
B	0.12 (0.2)		8.2
C	0.151	0.173	13 $\pm$ 3
D	0.254	0.334	7.1
E	0.319	0.411	4.0 $\pm$ 0.4
F	0.832	0.873	2.4
G	0.916	0.975	2.3

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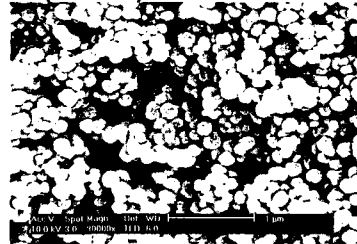
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## ***BaTiO<sub>3</sub> particles SEM***

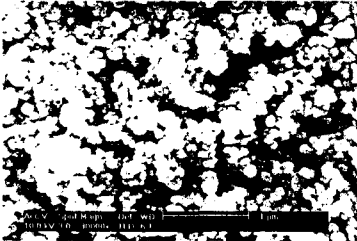
**A (60nm)**



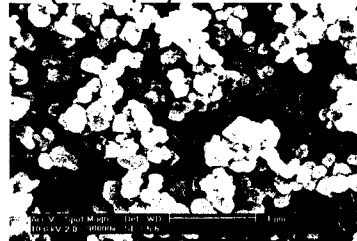
**B (120nm)**



**C (0.173 $\mu\text{m}$ )**



**D (0.334  $\mu\text{m}$ )**

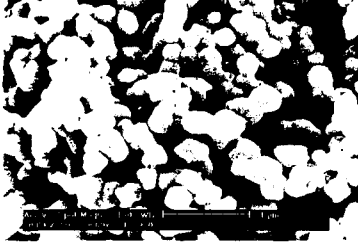


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## ***BaTiO<sub>3</sub> particle size: SEM***

**E (0.411 μm)**



**F (0.873 μm)**



**G (0.975 μm)**

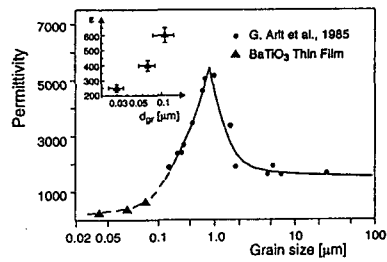
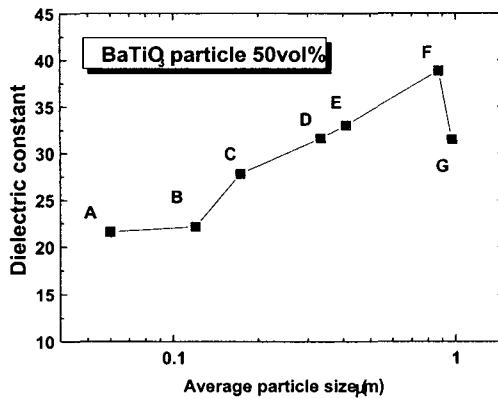


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## ***Particle size effects on dielectric constant***

• Particle volume fraction: 50vol%



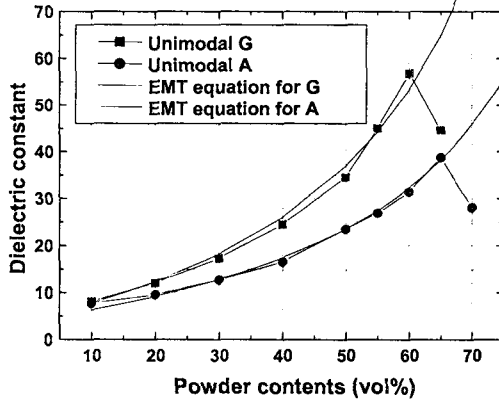
• F (0.87 μm) powder showed the highest dielectric constant

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## Particle volume fraction effect: Unimodal

G: 0.97 $\mu$ m, A : 0.06 $\mu$ m



• Modified EMT equation

$$\epsilon = \epsilon_p \left[ 1 + \frac{f_c (\epsilon_c - \epsilon_p)}{\epsilon_p + n(1 - f_c)(\epsilon_c - \epsilon_p)} \right]$$

$\epsilon_p$ : dielectric constant of polymer  
 $\epsilon_c$ : dielectric constant of ceramic  
 $f_c$ : ceramic particle volume fraction  
 $n$ : morphology factor

If  $\epsilon_p = 4$   
 For G (0.97 $\mu$ m)  
 $n = 0.12$ ,  $\epsilon_c = 5000$   
 For A (60nm)  
 $n = 0.18$ ,  $\epsilon_c = 300$

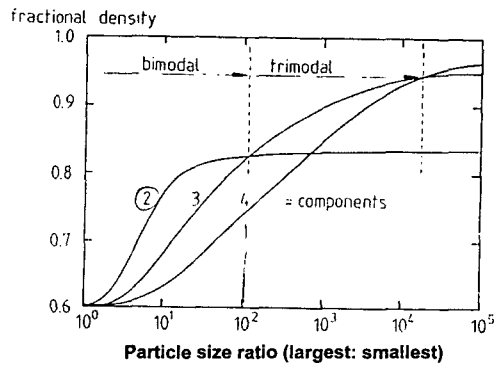
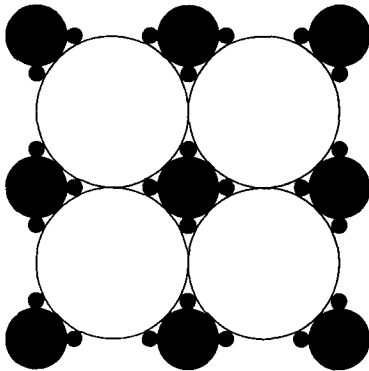
• Maximum packing density  
 G: 60vol%, A: 65vol%

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## Particle volume fraction effect: Multimodal

■ Multimodal Packing

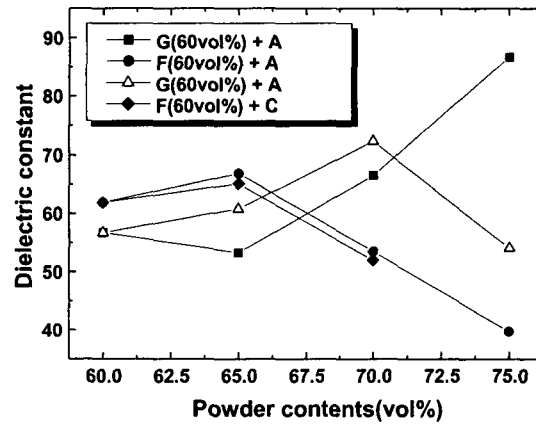


- Using trimodal powders, over 90vol% packing is possible
- Size ratio between coarser particle and smaller particle is important

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## **Bimodal Combination**



- F(0.87 $\mu$ m) is better for unimodal, but G(0.97 $\mu$ m) was more effective for higher volume loading of bimodal distribution.

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### ➤ **Embedded Capacitors**

#### **1. Embedded Capacitor Films(ECFs) Fabrication**

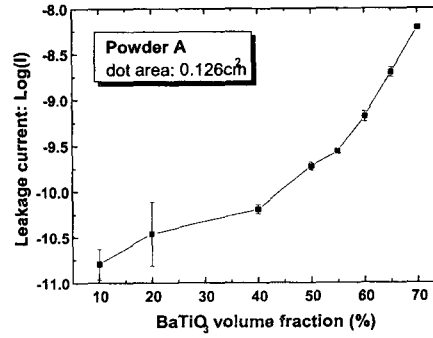
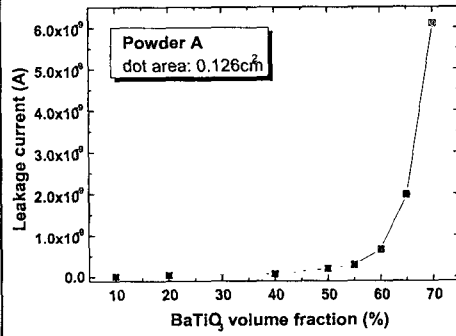
#### **2. Properties of ECFs**

- ✓ Tolerance
- ✓ Dielectric Constant
- ✓ Leakage Current
- ✓ Adhesion Strength



## BaTiO<sub>3</sub> Volume Fraction Effects

- Measurement condition  
5MV/m=5V/μm, step 1V from 0V  
equipment: Keithley 236 SMU

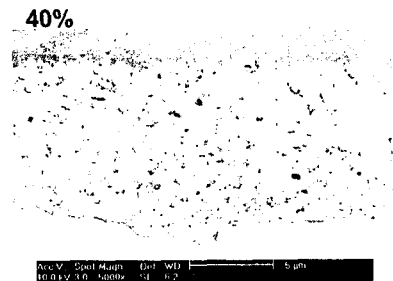
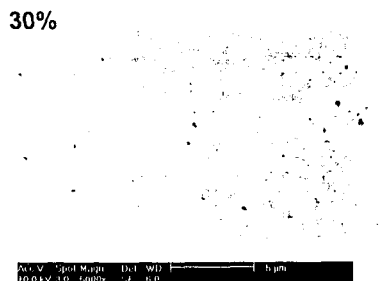
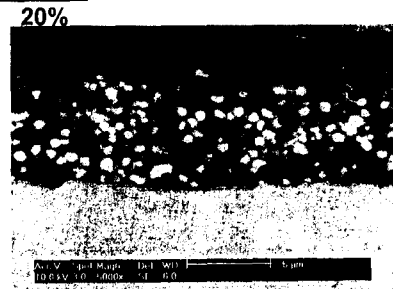
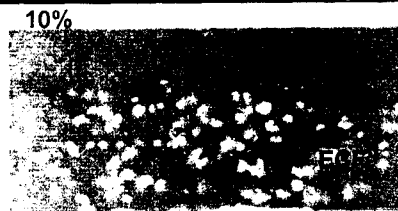


- Leakage current increased as particle volume fraction increased.

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## Cross Section Images of ECFs

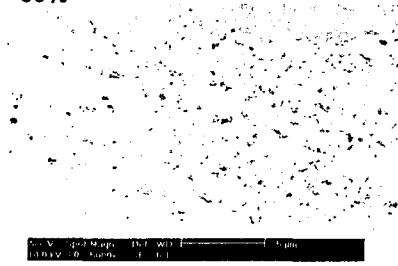


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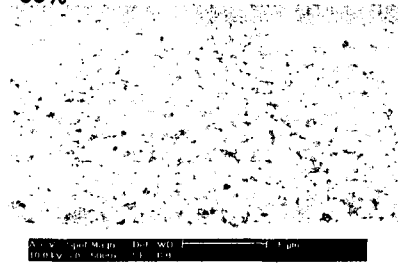
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## Cross Section Images of ECFs

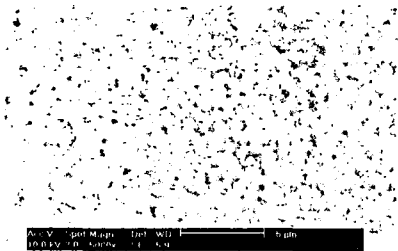
50%



55%



60%

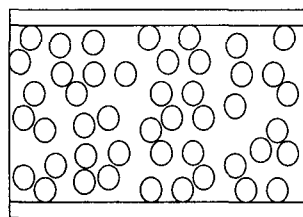


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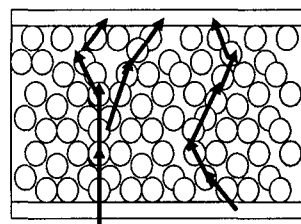
## Leakage Current Conduction in ECFs

Below percolation threshold



No connected path

Over percolation threshold



Conduction path formation

- BaTiO<sub>3</sub> is more conductive than epoxy, so it acts as stepping stones
- Epoxy surrounding the particles act as conduction barrier

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## ➤ Embedded Capacitors

### 1. Embedded Capacitor Films(ECFs) Fabrication

### 2. Properties of ECFs

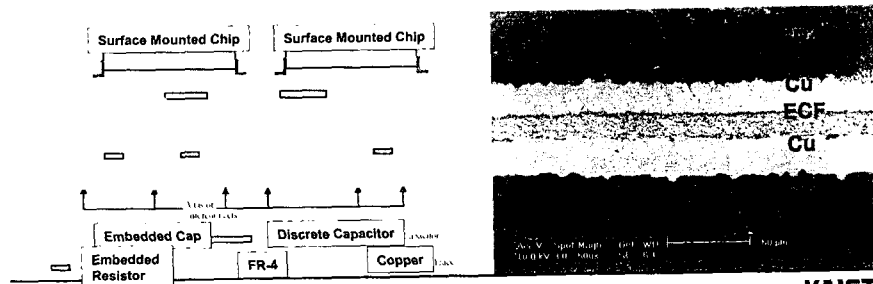
- ✓ Tolerance
- ✓ Dielectric Constant
- ✓ Leakage Current
- ✓ Adhesion Strength

## Adhesion of ECFs on Cu

### Variables

Required peel strength: 0.8kgf/cm

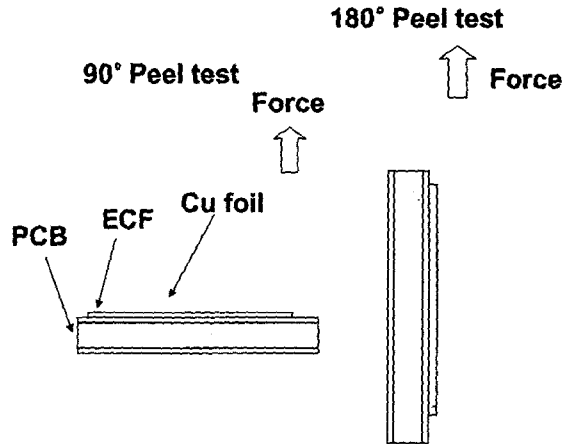
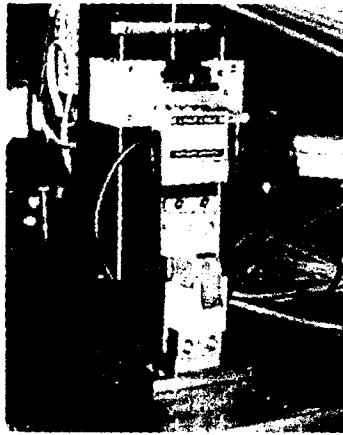
1. Solvent drying effects
  - Drying condition: 100°C, 30min
2. Effects of BaTiO<sub>3</sub> powder volume fraction
  - G powder(0.97μm) : 10 ~ 65vol%
3. Effects of BaTiO<sub>3</sub> particle size
  - 7 powders: 20vol%, 50vol%



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## Peel Strength Measurement



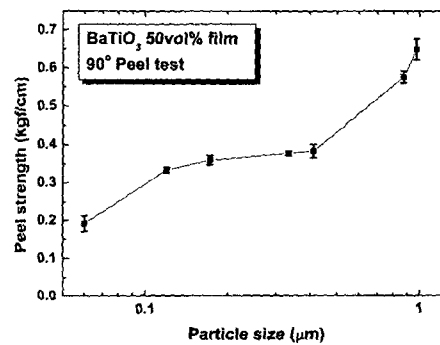
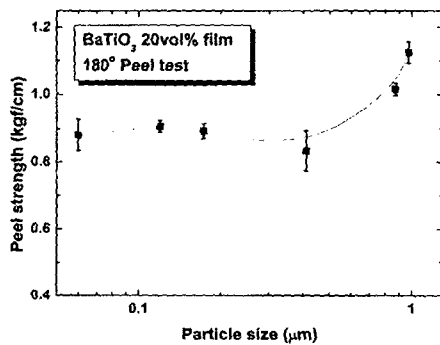
- Interface adhesion strength between ECF and Cu foil
- Smooth surface of Cu foil was used.
- Thickness: Cu foil-18 $\mu\text{m}$ , ECF- 10~20 $\mu\text{m}$

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## Particle Size Effects

- Lamination: 180°C, 50psi, 10min
- Shiny surface of Cu foil



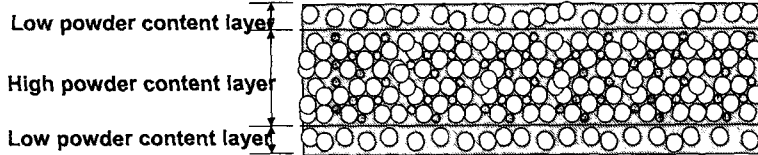
- Peel strength increased as particle size increased.

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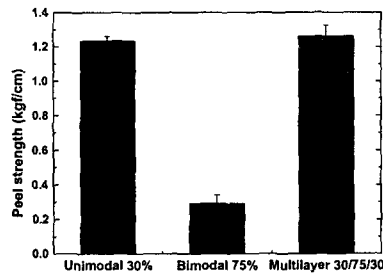
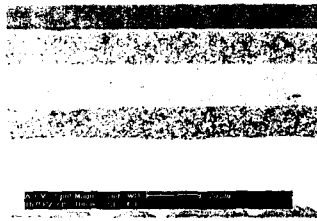
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## 3-layered ECFs (1)

### ➤ 3-layer ECF (Patent pending)



- Low powder content layer:  
→ Conduction barrier & adhesion layer
- High powder content layer:  
→ Main dielectric layer



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## Summary of ECFs

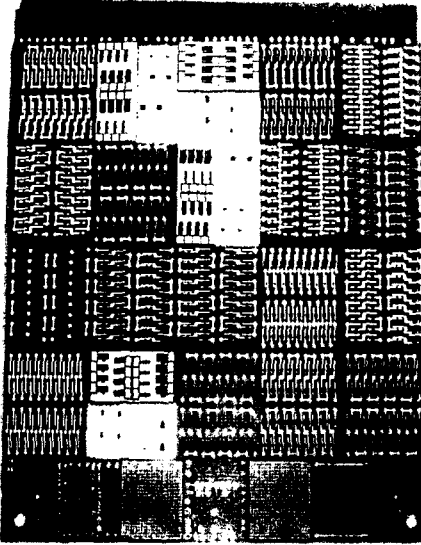
1. Embedded Capacitor Films with excellent properties were newly developed.  
ECF capacitors with low tolerance (less than  $\pm 5\%$ ) and high dielectric constant of 93 were successfully demonstrated on PCBs.  
60% of discrete capacitors ( $< 100\text{nF}$ ) for cell phones applications can be replaced by embedded capacitors.
2. For higher dielectric constant ECFs,  
Optimum  $\text{BaTiO}_3$  particle size for unimodal was  $0.87\mu\text{m}$ ,  
and Higher powder loading over 75% is needed.  
However, adhesion and leakage current problem should be optimized.

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## Printed Embedded Resistors

Conductive Polymer Resistors,  $<200\Omega/\text{sq}$ ,  $\sim 1\text{mm}$  long

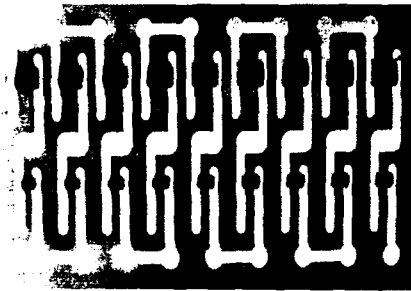


- Polyimide resistors
- Resistor size: 0.125–1.375 mm
- Daisy chain vs. Isolated
- 125, 250 and 500  $\mu\text{m}$  Cu conductors

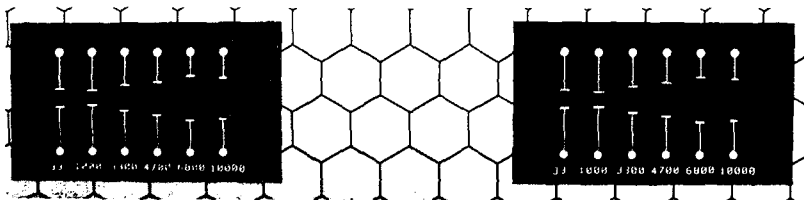
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## Printed Embedded Resistors



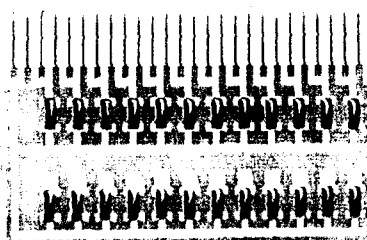
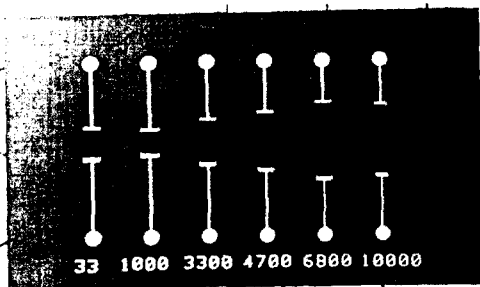
- Well defined printed edges
- Additive, non-contact, digital printing process
- Easy set up and modification



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## Printed Embedded Resistor

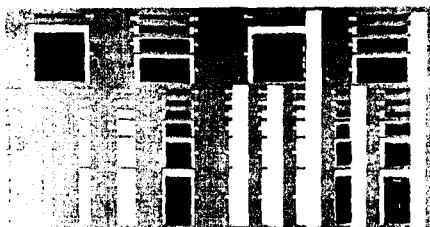
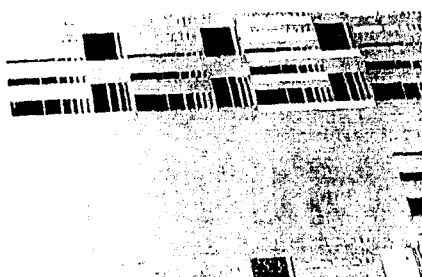


UV-curable resistor

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## Embedded Resistor Trimming



A portion of Ni/P plated Test Vehicle inner layer trimmed down using ICP and Ink jet printing

- Ni/P plated trimmed by ICP.
- Demonstrated trim down: up to 35%
- Resistor size trimmed
  - 10 mil – 330 mil

Trimming Target: 40 ohm/square

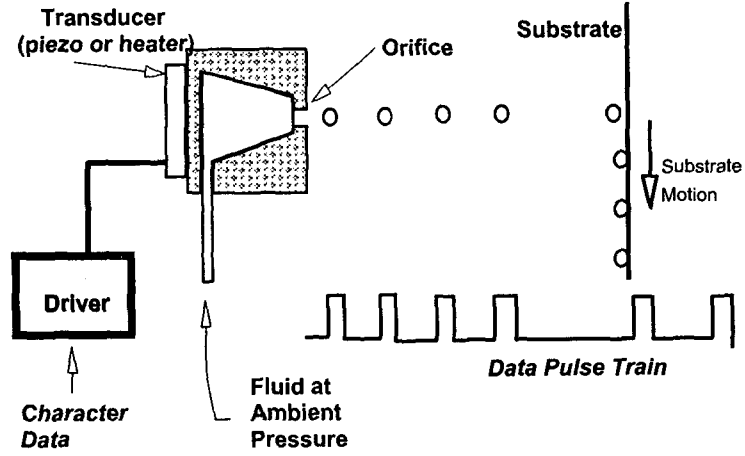
Size mil	Before Trimming		After Trimming	
	Average	Std Dev	Average	Std Dev
320x170	51.4	8.1	38.7	5.8
160x170	54.4	11.4	42.2	9.6
80x170	53.9	9.3	40.9	9.1
40x170	53.7	9.3	38.9	7.2
20x170	55.7	12.0	40.4	9.4
10x170	53.9	6.3	42.8	9.5

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## Ink-Jet Resistor Technology

*15-150 $\mu$ m droplets, 0-25kHz*



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## Drop-on-Demand Technology

*60 $\mu$ m droplets of alcohol, 4kHz*

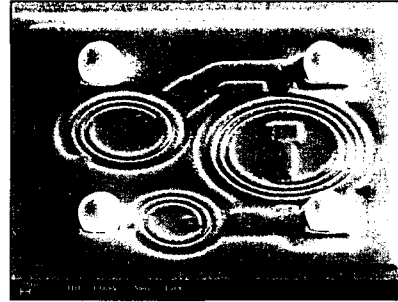
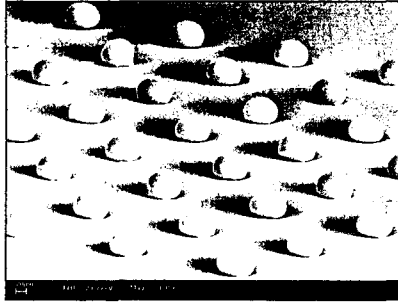


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## Solder Jet



- Eutectic Pb/Sn solder bumps
- Various bump size

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## Ink-Jet Microdispensing Advantages

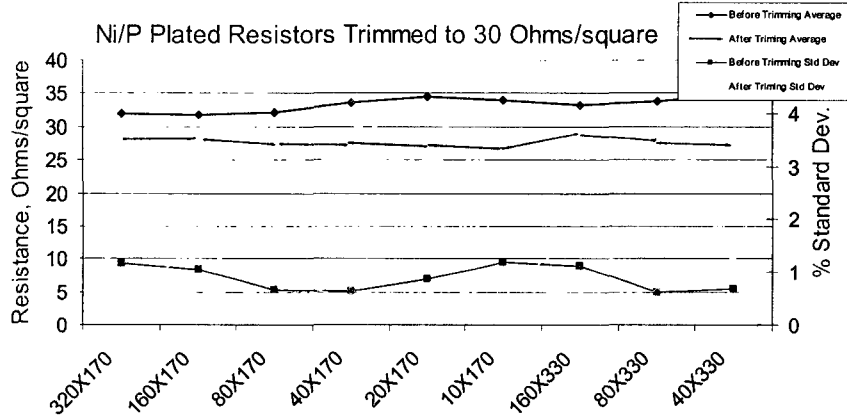
- Direct-write of materials
  - data-driven (flexible, low cost)
  - additive (environmentally friendly, low cost)
  - non-contact
  - thick films possible
- Wide range of materials
  - biological, metals, polymers, fluxes ...
  - wide operating temperature range (0-370C)
- Wide range of resolutions
  - 15-120um drops + N drops per spot
- Wide range of rates
  - 1Hz - 1MHz

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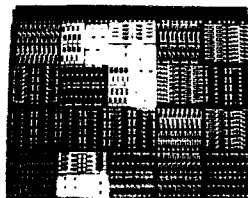
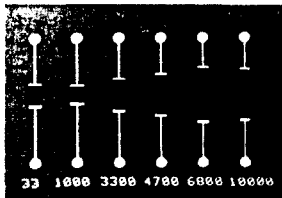
## Embedded Resistor Trimming Results



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## Embedded Resistors Printing/Trimming using Drop-on-demand



Size (mil)	TV-2R Inner Layer-4 (Ni/P plated resistor using ICP)			
	Before Trimming		After Trimming	
	Avg (Ω/sq)	STD(%)	Avg	STD(%)
320 x 170	51.4	8.1	38.7	5.8
160 x 170	54.4	11.4	42.2	9.6
80 x 170	53.9	9.3	40.9	9.1
40 x 170	53.7	9.3	38.9	7.2
20 x 170	55.7	12.0	40.4	9.4
10 x 170	53.9	6.3	42.8	9.5

• Ink-jet printed embedded resistor using conductive polymer  
(From AEPT consortium)

• Embedded Ni/P resistor trimmed by ICP

### Key points of Embedded Resistors Printing

- Development of new resistor materials for ink-jet printing
  - Investigation of Fluid viscosity(<40cps), Surface tension(20-70dyne/cm), Stable droplet dispersion
- Demonstration of resistor printing and curing processes
  - Dispensing temp, Volume control of dispensed droplets, Curing parameters
  - Resistor properties : Resistance, Tolerance, TCR (Temp. Coeff. of Resistance)

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